

# N-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}$ ( $\Omega$ )	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)		
60	0.032 at V <sub>GS</sub> = 10 V	5.5	2.3 nC		
80	0.036 at V <sub>GS</sub> = 4.5 V	3.1	2.3110		

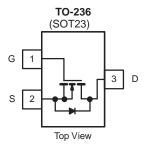
#### **FEATURES**

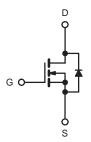
- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>g</sub> Tested
- 100 % UIS Tested



#### **APPLICATIONS**

- Battery Switch
- DC/DC Converter





N-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	60	V		
Gate-Source Voltage		V <sub>GS</sub>			± 20
	T <sub>C</sub> = 25 °C		5.5		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	_	4.8		
Continuous Diain Current (1) = 130 °C)	T <sub>A</sub> = 25 °C	ID	4.9 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		3.5 <sup>b, c</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	20	_ ^	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	1-	1.59		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	0.91 <sup>b, c</sup>		
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	6		
Single-Pulse Avalanche Energy	L = 0.1 IIII	E <sub>AS</sub>	1.8	mJ	
	T <sub>C</sub> = 25 °C		1.66		
Mayimum Dawar Dissination	T <sub>C</sub> = 70 °C	D	1.06	W	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	1.09 <sup>b, c</sup>	vv	
	T <sub>A</sub> = 70 °C		0.7 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stq</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RAT	RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	≤ 5 s	$R_{thJA}$	70	95	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	60	75	C/VV	

#### Notes:

- a. Based on  $T_C = 25$  °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. Maximum under Steady State conditions is 130 °C/W.



MOSFET SPECIFICATIONS  Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static					1	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{DS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$				V
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>			55		mc\ //0:
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 5		mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1		3	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zana Oata Valtana Brain Ourrant		$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$			1	μА
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	8			А
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.9 A		0.032	0.036	1
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 1.7 A		0.036	0.039	Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15V, I <sub>D</sub> = 1.9 A		5		S
Dynamic <sup>b</sup>	1				1	
Input Capacitance	C <sub>iss</sub>			190		
Output Capacitance	C <sub>oss</sub>			26		
Reverse Transfer Capacitance	C <sub>rss</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		15		pF
		V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.9 A		4.5	6.8	
Total Gate Charge	$Q_g$			2.3 3.	3.5	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 1.9 \text{ A}$		0.8		
Gate-Drain Charge	$Q_{gd}$			1		
Gate Resistance	R <sub>g</sub>	f = 1 MHz	0.6	2.8	5.6	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			4	6	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 30 V, $R_L$ = 20 $\Omega$		10	15	ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ 1.5 A, $V_{GEN}$ = 10 V, $R_G$ = 1 $\Omega$		10	15	
Fall Time	t <sub>f</sub>			7	10.5	
Turn-On Delay Time	t <sub>d(on)</sub>			15	23	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 30 V, $R_L$ = 20 $\Omega$		16	24	ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 1.5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_G = 1 \Omega$		11	17	
Fall Time	t <sub>f</sub>			11	17	1
<b>Drain-Source Body Diode Characteristi</b>	cs					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			2.39	^
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>		·		8	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 1.5 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			15	23	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L = 1.5 A dl/dt = 100 A/va T = 25 °C		10	15	nC
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 1.5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		12		
Reverse Recovery Rise Time	t <sub>b</sub>			3		ns

#### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

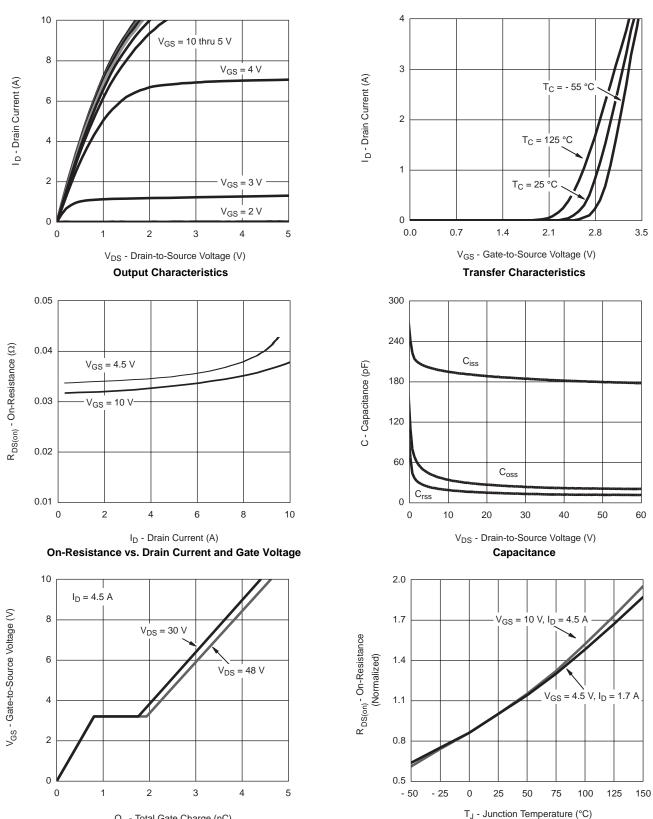
<sup>a. Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2 %.
b. Guaranteed by design, not subject to production testing.</sup> 



## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Q<sub>g</sub> - Total Gate Charge (nC)

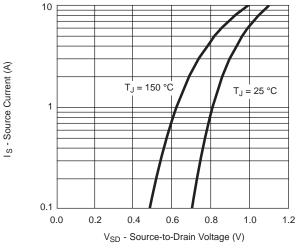
**Gate Charge** 



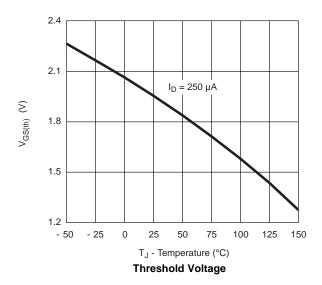
On-Resistance vs. Junction Temperature

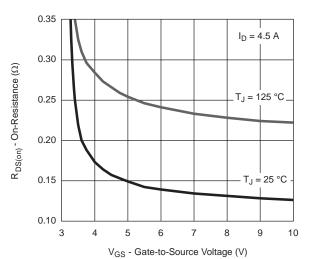


### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

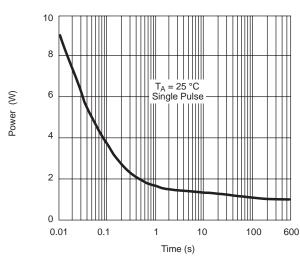


#### Source-Drain Diode Forward Voltage

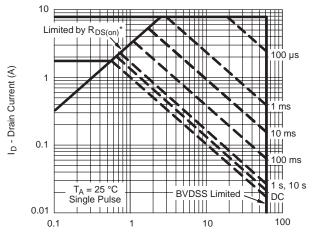




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power



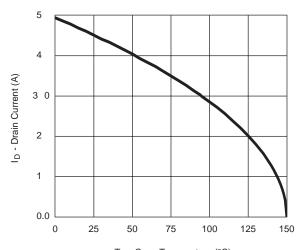
V<sub>DS</sub> - Drain-to-Source Voltage (V)

#### Safe Operating Area

<sup>\*</sup>  $V_{\mbox{\footnotesize{GS}}} >$  minimum  $V_{\mbox{\footnotesize{GS}}}$  at which  $R_{\mbox{\footnotesize{DS(on)}}}$  is specified

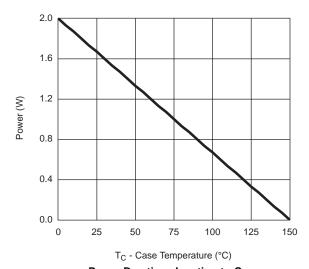


### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

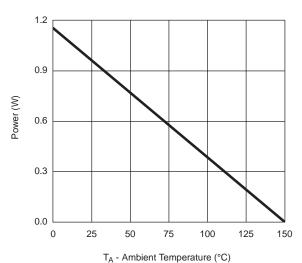


T<sub>C</sub> - Case Temperature (°C)

### Current Derating\*



Power Derating, Junction-to-Case

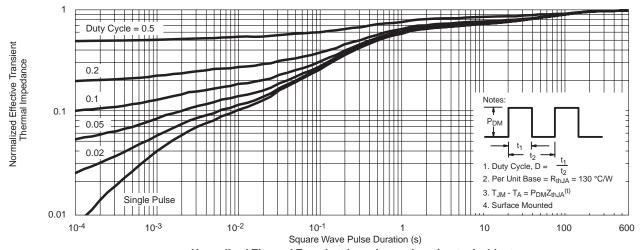


Power Derating, Junction-to-Ambient

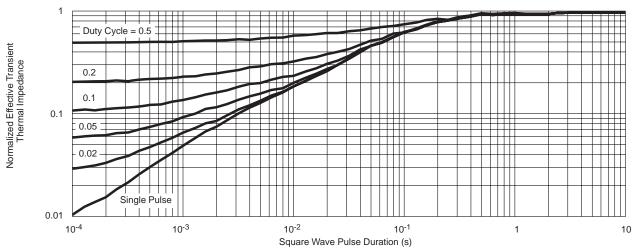
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



## **THERMAL RATINGS** ( $T_A = 25$ °C, unless otherwise noted)



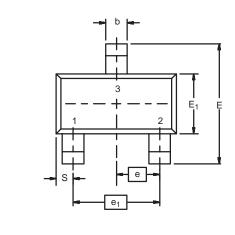
Normalized Thermal Transient Impedance, Junction-to-Ambient

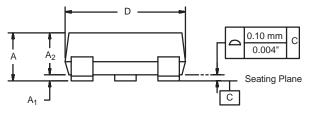


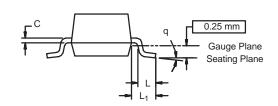
Normalized Thermal Transient Impedance, Junction-to-Foot



## SOT-23 (TO-236): 3-LEAD







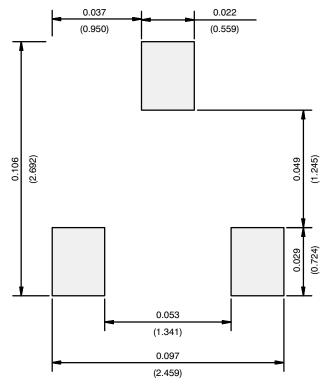
Dim -	MILLIM	IETERS	INCHES			
	Min	Max	Min	Max		
Α	0.89	1.12	0.035	0.044		
A <sub>1</sub>	0.01	0.10	0.0004	0.004		
A <sub>2</sub>	0.88	1.02	0.0346	0.040		
b	0.35	0.50	0.014	0.020		
С	0.085	0.18	0.003	0.007		
D	2.80	3.04	0.110	0.120		
E	2.10	2.64	0.083	0.104		
E <sub>1</sub>	1.20	1.40	0.047	0.055		
е	0.95 BSC		0.0374 Ref			
e <sub>1</sub>	1.90	1.90 BSC		0.0748 Ref		
L	0.40	0.60	0.016	0.024		
L <sub>1</sub>	0.64 Ref		0.025	Ref		
S	0.50 Ref		0.020	Ref		
q	3°	8°	3°	8°		

ECN: S-03946-Rev. K, 09-Jul-01

DWG: 5479



#### **RECOMMENDED MINIMUM PADS FOR SOT-23**



Recommended Minimum Pads Dimensions in Inches/(mm)





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